



Product data sheet

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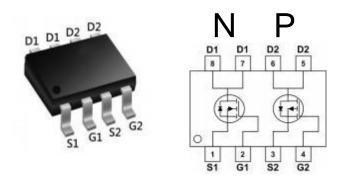




Product Summary

BVDSS	RDSON	ID
60V	65mΩ	4.8A
-60V	75mΩ	-3.7A

SOP8 Pin Configuration



- ★ Super Low Gate Charge
- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

Description

The MS4559 is the high performance complementary N-ch and P-ch MOSFETs with high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The MS4559 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Absolute Maximum Ratings

		Rat	Rating	
Symbol	Parameter		P-Channel	Units
Vds	Drain-Source Voltage	60	-60	V
Vgs	Gate-Source Voltage	±20	±20	V
ID@TA=25°C	Continuous Drain Current, VGS @ 10V1	4.8	-3.7	А
ID@TA=70°C	Continuous Drain Current, V _{GS} @ 10V ¹	3.8	-3	А
Ідм	Pulsed Drain Current ²	9.6	-7.5	А
EAS	Single Pulse Avalanche Energy ³	25.5	35.3	mJ
las	Avalanche Current	22.6	-26.6	А
PD@TA=25°C	Total Power Dissipation ⁴	1.5	1.5	W
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction-Ambient ¹		85	°C/W
Rejc	Thermal Resistance Junction-Case ¹		36	°C/W



MS4559 HF Compiance

N-Channel Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	nbol Parameter Conditions		Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV$ DSS/ $\triangle T_J$	BVDSS Temperature Coefficient	Reference to 25°C ,ID=1mA		0.063		V/°C
Descer	Otatia Dania Osumo Os Danistanos?	Vgs=10V , Ib=4A		65	80	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =2A		75	95	mΩ
VGS(th)	Gate Threshold Voltage		1.2		2.5	V
riangle VGS(th)	V _{GS(th)} Temperature Coefficient	──Vgs=Vbs , Ib =250uA		-5.24		mV/°C
I	Drein Source Leekage Current	V _{DS} =48V , V _{GS} =0V , T _J =25°C			1	
IDSS	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55°C			5	uA
lgss	Gate-Source Leakage Current	V _{GS=} ±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	VDS=5V , ID=4A		21		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		3.2		Ω
Qg	Total Gate Charge (4.5V)			12.6		
Qgs	Gate-Source Charge	VDS=48V , VGS=4.5V , ID=4A		3.2		nC
Qgd	Gate-Drain Charge			6.3		
Td(on)	Turn-On Delay Time			8		
Tr	Rise Time	VDD=30V , VGS=10V , RG=3.3Ω ,		14.2		
Td(off)	Turn-Off Delay Time	ID=4A		24.4		ns
Tf	Fall Time			4.6		
Ciss	Input Capacitance	vitance VDs=15V , VGs=0V , f=1MHz		1378		
Coss	Output Capacitance			86		pF
Crss	Reverse Transfer Capacitance			64		

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,5}				4.8	А
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			9.6	А
Vsd	Diode Forward Voltage ²	Vgs=0V , Is=1A , TJ=25°C			1.2	V

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%

3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0. 1mH, I_{AS} =22.6A

4. The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Semiconductor Compiance

MS4559

P-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	mbol Parameter Conditions		Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , I₀=-250uA	-60			V
∆BVbss/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C ,I⊳=-1mA		-0.03		V/°C
Decision	Otatia Dania Oscara Oscolatorea 2	Vgs=-10V , Id=-3A		75	90	
RDS(ON)	Static Drain-Source On-Resistance ²	Vgs=-4.5V , Ib=-2A		90	125	mΩ
VGS(th)	Gate Threshold Voltage		-1.2		-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			4.56		mV/°C
	Drain Source Leekege Current	V _{DS} =-48V , V _{GS} =0V , T _J =25°C			1	
ldss	Drain-Source Leakage Current	V _{DS} =-48V , V _{GS} =0V , T _J =55°C			5	uA
lgss	Gate-Source Leakage Current	V _{GS=} ±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	VDS=-5V , ID=-3A		15		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		13.5		Ω
Qg	Total Gate Charge (-4.5V)			9.86		
Qgs	Gate-Source Charge	Vds=-48V , Vgs=-4.5V , Id=-3A		3.1		nC
Qgd	Gate-Drain Charge			2.95		
Td(on)	Turn-On Delay Time			28.8		
Tr	Rise Time	VDD=-15V , VGS=-10V , RG=3.3Ω ,		19.8		
Td(off)	Turn-Off Delay Time	ID=-1A		60.8		ns
Tf	Fall Time			7.2		
Ciss	Input Capacitance	VDS=-15V , VGS=0V , f=1MHz		1447		
Coss	Output Capacitance			97.3		pF
Crss	Reverse Transfer Capacitance			70		

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,5}				-3.7	А
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			-7.5	A
Vsd	Diode Forward Voltage ²	Vgs=0V , Is=- 1A , Tj=25°C			-1.2	V

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\leq~300 us$, duty cycle $\leq~2\%$

3. The EAS data shows Max. rating . The test condition is V_{DD}=-25V,V_{GS}=-10V,L=0. 1mH,I_{AS}=-26.6A

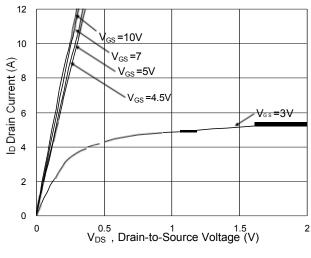
4. The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

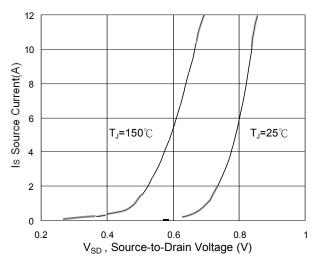


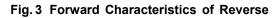
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N-Channel Typical Characteristics









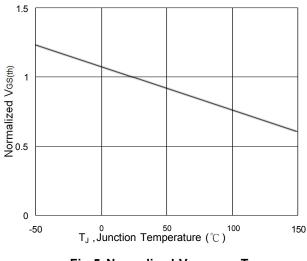


Fig.5 Normalized $V_{GS(th)} v.s T_J$

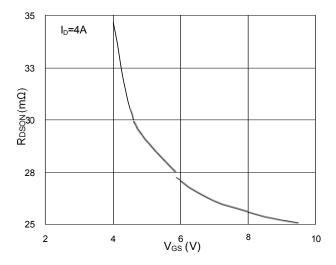


Fig.2 On-Resistance v.s Gate-Source

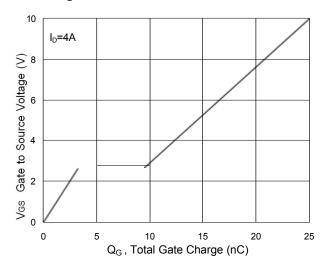
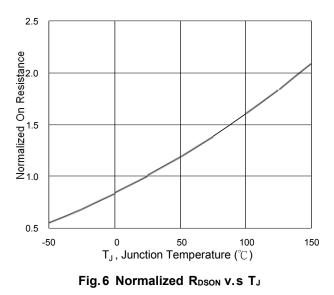


Fig. 4 Gate-Charge Characteristics





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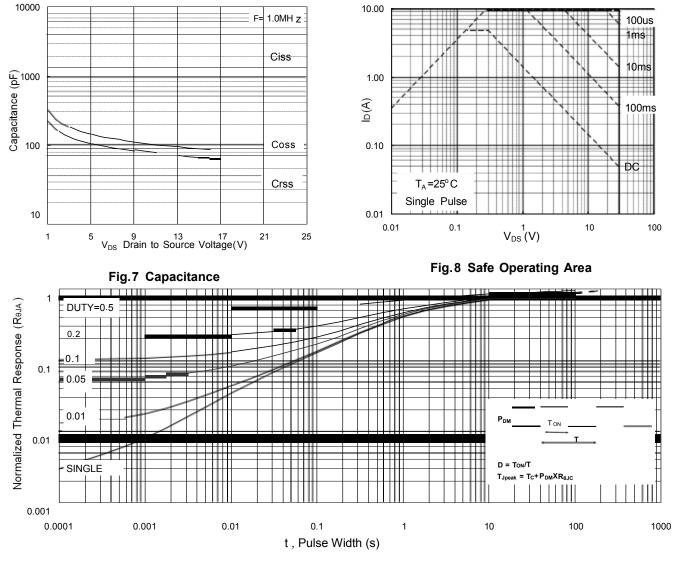


Fig. 9 Normalized Maximum Transient Thermal Impedance

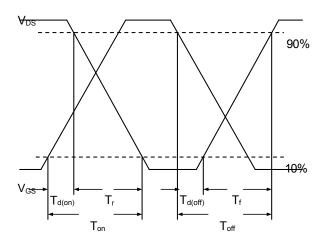


Fig.10 Switching Time Waveform

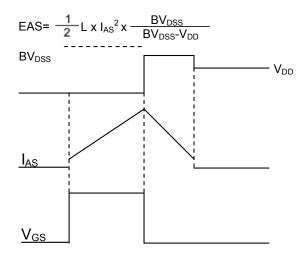


Fig.11 Unclamped Inductive Waveform



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P-Channel Typical Characteristics

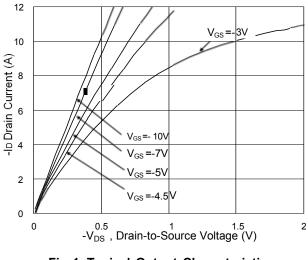


Fig.1 Typical Output Characteristics

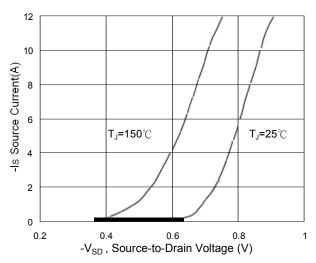


Fig. 3 Forward Characteristics of Reverse

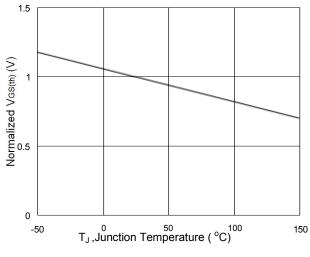


Fig.5 Normalized V_{GS(th)} v.s T_J

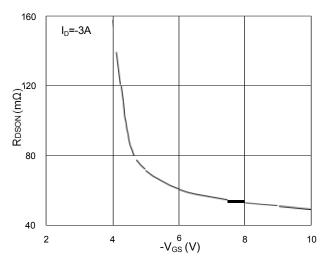


Fig.2 On-Resistance v.s Gate-Source

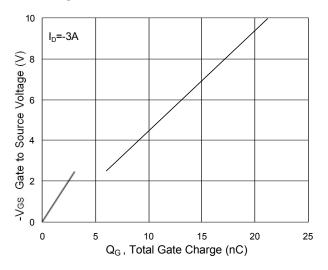


Fig.4 Gate-Charge Characteristics

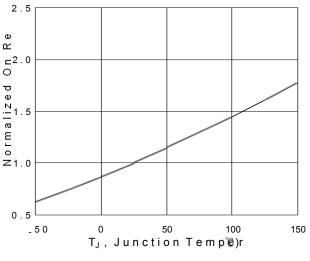


Fig.6 Normalized R_{DSON} v.s T_J





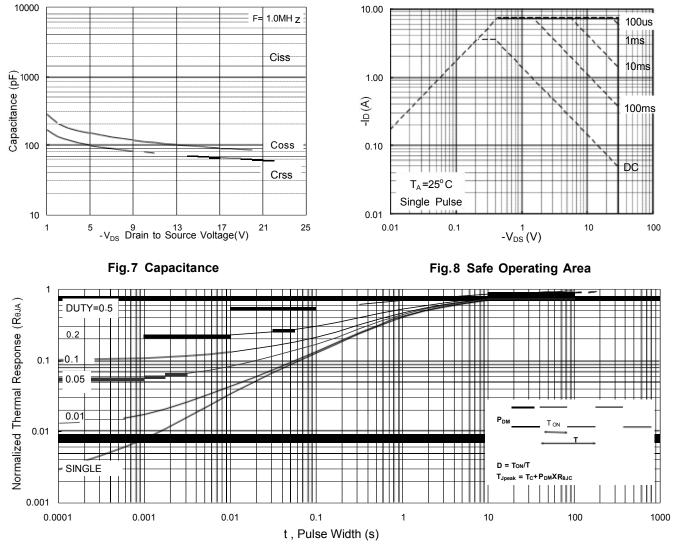


Fig. 9 Normalized Maximum Transient Thermal Impedance

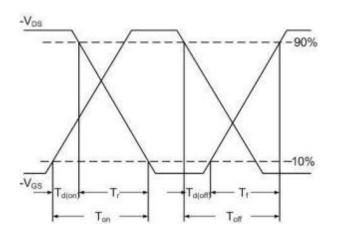
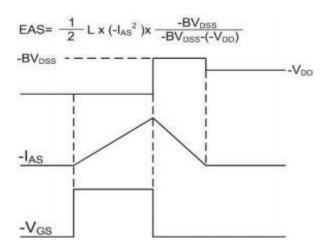


Fig.10 Switching Time Waveform

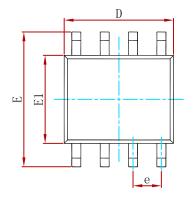


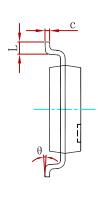


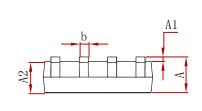




PACKAGE MECHANICAL DATA

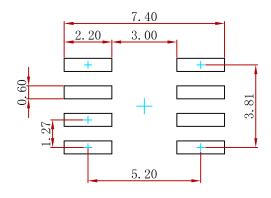






Symbol	Dimensions In	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
с	0.170	0.250	0.007	0.010
D	4.800	5.000	0.189	0.197
e	1.270 ((BSC)	0.050 (BSC)	
Е	5.800	6.200	0.228	0.244
E1	3.800	4.000	0.150	0.157
L	0.400	1.270	0.016	0.050
θ	0°	8°	0 °	8°

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.
3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
MS4559	SOP-8	3000



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